AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions and listings of claims in the application:

LISTING OF CLAIMS:

 (Currently amended): A multiple wavelength surface-emitting laser device comprising:

a substrate; and

a plurality of surface-emitting lasers that are formed on the substrate by a continuous manufacturing process,

wherein each of said plurality of surface-emitting lasers comprises:

a bottom reflection layer on the substrate, that is doped with impurities of a first type and that is composed of alternating semiconductor material layers having different refractive indexes;

an active layer on the bottom reflection layer;

an intermediate layer that is doped with impurities of a second type on the active layer;

a top electrode on the intermediate layer, said top electrode having a window through which light is emitted; and

a dielectric reflection layer where dielectric materials with different refractive indexes are alternately layered on the intermediate layer and the top electrode to be dielectric layers of a thickness suitable for a desired selected resonance wavelength, whereby the desired selected

resonance wavelength is controlled by adjusting the thickness of the dielectric layers of the dielectric reflection layer.

- 2. (Original) The multiple wavelength surface-emitting laser of claim 1, wherein the dielectric reflection layer is composed of two different dielectric materials with different refractive indexes.
- 3. (Original) The multiple wavelength surface-emitting laser of claim 2, wherein the dielectric reflection layer is composed of any two dielectric materials selected from the group consisting of TiO₂, Ta₂O₅, ZrO₂, HfO, SiO₂ and MgF₂.
- 4. (Original) The multiple wavelength surface-emitting laser of claim 1, wherein the dielectric reflection layer is composed of any two dielectric materials selected from the group consisting of TiO₂, Ta₂O₅, ZrO₂, HfO, SiO₂ and MgF₂.
- 5. (Original) The multiple wavelength surface-emitting laser device of claim 1 further comprising a high resistance part that confines electric current between the active layer and the top electrode.
- 6. (Currently amended): A method of manufacturing a multiple wavelength surfaceemitting laser device comprising the steps of

sequentially forming, on a prepared substrate, a bottom reflection layer, that is doped with impurities of a first type and composed of alternating semiconductor material layers having different refractive indexes, an active layer and an intermediate layer that is doped with impurities of a second type;

forming an arrangement of a plurality of surface-emitting lasers by removing, from a region separating the surface emitting lasers, the intermediate layer, the active layer and a part of the bottom reflection layer by etching;

forming on the intermediate layer of each surface-emitting laser a top electrode having a window through which light is emitted; and

forming on at least one of the intermediate layer and the top electrode of each surfaceemitting laser, a dielectric reflection layer where different dielectric materials are alternately
layered to be dielectric layers of a thickness suitable for a desired selected resonance wavelength,
whereby the desired selected resonance wavelength is controlled by adjusting the thickness of
the dielectric layers of the dielectric reflection layer.

- 7. (Original) The method for manufacturing a multiple wavelength surface-emitting laser device of claim 6, wherein the dielectric reflection layer is composed of two different dielectric materials with different refractive indexes.
- 8. (Original) The method for manufacturing a multiple wavelength surface-emitting laser device of claim 7, wherein the dielectric reflection layer is composed of any two dielectric materials selected from the group consisting of TiO₂, Ta₂O₅, ZrO₂, HfO, SiO₂ and MgF₂.
- 9. (Original) The method for manufacturing the multiple wavelength surface-emitting laser device of claim 7, wherein the dielectric reflection layer is formed by using an optical deposition unit.

- 10. (Original) The method for manufacturing the multiple wavelength surface-emitting laser of claim 6, wherein the dielectric reflection layer is composed of any two dielectric materials selected from the group consisting of TiO₂, Ta₂O₅, ZrO₂, HfO, SiO₂ and MgF₂.
- 11. (Original) The method for manufacturing the multiple wavelength surface-emitting laser device of claim 6, wherein the dielectric reflection layer is formed by using an optical deposition system.
- 12. (Original) The method for manufacturing the multiple wavelength surface-emitting laser of claim 6 further comprising a step of forming a high resistance part that confines electric current between the active layer and the top electrode.
- 13. (Currently amended): A multiple wavelength surface-emitting laser device comprising:

a substrate; and

a plurality of surface-emitting lasers formed on the substrate by a continuous manufacturing process,

wherein each of said plurality of surface-emitting lasers comprises:

a bottom reflection layer on the substrate, that is doped with impurities of a first type and that is composed of alternating semiconductor material layers having different refractive indexes;

an active layer on the bottom reflection layer;

an intermediate layer that is doped with impurities of a second type on the active layer;

a top electrode on the intermediate layer, said top electrode having a window through which light is emitted; and

a dielectric reflection layer comprising dielectric layers composed of dielectric materials with different refractive indexes alternately layered on the intermediate layer and the top electrode so that a thickness of the dielectric layers is optimized for a desired selected resonance wavelength, whereby the desired selected resonance wavelength is controlled by adjusting the thickness of the dielectric layers of the dielectric reflection layer.